

EXPEDITED PROCEDURE – EXAMINING GROUP 2857

S/N 09/834,751

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:	Sergey A. Velichko et al.	Examiner:	Manuel L. Barbee
Serial No.:	09/834,751	Group Art Unit:	2857
Filed:	April 13, 2001	Docket No.:	303.750US1
Title:	CONCURRENT CONTROL OF SEMICONDUCTOR PARAMETRIC TESTING		

AMENDMENT & RESPONSE UNDER 37 C.F.R. 1.116

Mail Stop AF
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

In response to the Final Office Action mailed October 27, 2006, please amend the application as follows: